




Search Notes 	Application/Control No. 10620045	Applicant(s)/Patent Under Reexamination BHATTACHARYA ET AL.
	Examiner Jacob, Mary C	Art Unit 2123

Notes	Date	Examiner
Inventor Name Search: EAST, EDAN, Google Scholar	06/06/2006	MCJ
Assignee Name Search: EAST, Google Scholar	06/06/2006	MCJ
IEEE: switch fabric, simulate, chip set	06/06/2006	MCJ
Google: agere, chipset, simulation, user	06/06/2006	MCJ
Search on Rsoft website	06/06/2006	MCJ
IEEE: chip set, network, design, optical	06/08/2006	MCJ
EAST: See Search History	6/6/06, 6/7/06	MCJ
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<p>Searched</p> 	<p>Application/Control No.</p> <p>10620045</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>BHATTACHARYA ET AL.</p>
	<p>Examiner</p> <p>Jacob, Mary C</p>	<p>Art Unit</p> <p>2123</p>

Class	SubClass	Date	Examiner
703	14	6/7/06	MCJ

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